A shton, et al.

Sept. 3, 2003

This Information Disclosure Statement is submitted:

() under 37 CFR 1.97 (d) together with a:

() under 37 CFR 1.97(c) together with either a: () Statement under 37 CFR 1.97(e), or () a \$180.00 fee under 37 CFR 1.17(p), or

under 37 CFR 1.97(b), or

Inventor(s):

Filing Date:

PO Box 1450

Title:

Sir:

Application No.:

Commissioner for Patents

Alexandria, VA 22313-1450

PATENT APPLICATION

ATTORNEY DOCKET NO. 100201669-1

Confirmation No.:

Group Art Unit:

Examiner:

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT

(Within three months of filing national application; or date of entry of national application; or before

(After the CFR 1.97 (b) time period, but before final action or notice of allowance, whichever occurs first)

(Filed after final action, a notice of allowance, on or before payment of the issue fee)

CELLS AND METHODS OF FABRICATION THEREOF

mailing date of first office action on the merits; whichever occurs last)

() Statement under 37 CFR 1.97(e)(1) or (2), and) a \$180.00 fee set forth in 37 CFR 1.17(p).

ULTRA-HIGH DENSITY STORAGE DEVICE USING PHASE CHANGE DIODE MEMORY

Please charge to Deposit Account 08-2025 the sun pendency of this application, please charge any fees re Account 08-2025 pursuant to 37 CFR 1.25.	n of <u>\$0.00</u> . At any time during the equired or credit any overpayment to Deposit
(X) Applicant(s) submit herewith Form PTO 1449 - copies, of patents, publications or other information of w believe(s) may be material to the examination of this apprendisclose in accordance with 37 CFR 1.56.	hich applicant(s) are aware, which applicant(s)
() A concise explanation of the relevance of foreign I and other foreign language information listed on PTO individuals(s) designated in 37 CFR 1.56 (c) most know attached sheet, or where a foreign language patent is foreign patent office in a counterpart foreign application report or action which indicates the degree of relevance for 1449 and is enclosed herewith.	Form 1449, as presently understood by the redgeable about the content is given on the cited in a search report or other action by a search report or other action by a search register.
It is requested that the information disclosed herein be ma	ade of record in this application.
"Express Mail" label no. EL 980208664 US Date of Deposit Sept. 3, 2003	Respectfully submitted, Ashton, et al.
I hereby certify that this is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 CFR 1.10 on the date indicated above and is addressed to: Commissioner for Patents, Washington, D.C.	By Lauren Wolfell Vaughn W. North
20231.	Attaurant (Amont for Amolioant(a)

Attorney/Agent for Applicant(s)

27,930 Reg. No.

Date: Sept. 3, 2003

Rev 05/03 (IDSXML)

Typed Name: Vaughn W. North

Telephone No.: (801) 566-6633

Sheet 1 of 5

FORM PTO-1449				ATTY. DOCKET NO.	APPLICATION NO	CONFIRMA	TION NO		
			JBLICATIONS FOR		100201669-1				
		NT'S INFORMATI	ON DISCLOSURE		A PPLICANT				
		STATE	MENT		Ashton, et al	GROUP			
	(Use	e several sheets i	f necessary)		Sept. 3, 2003				
REFEREN	CE D	ESIGNATION	U.S. P	ATEN	T DOCUMENTS				
X A MINER INITIA L		DOCUMENT NUMBER	PUBLICATION DATE		NAME	Pages, Colum Relevant Passage	Pages, Columns, Lines Where Relevant Passages or Figures Appear		
	1A 5,557,596 09/17/96 G		Gib	son et al					
	1B 6,	,256,224	07/03/01	Per	ner, et al.				
	1C 6,	,262,421	07/17/01	Tra	n				
	1D								
	1E								
	1F								
	1G								
	1H							 -	
	11			_					
	1J								
	1K							<u> </u>	
			FO	REIGN	PATENT DOCUME	ENTS		Check if	
		DOCUMENT NUMBER	PUBLICATION DATE	N	AME OF PATENTEE OR APPLICANT	Pages/Columns/L Relevant Passages/F		Translatio	
	1L								
	1 M								
	1N								
	10								
	1P								
		OTHER REF	ERENCES (includi	ing Aı	ithor, Title, Date, P	Pertinent Pages, etc	.)		
	1Q	Kampmann, e Using a ITO/II	t al. A Cadmium-fre n2Se3/CuInSe2/Au	ee Culr Struct	nSe2 Superstrate Sola ure; Progress in Phot	ar Cell Fabricated by ovoltaics; (1999) pgs	Electrodeposit 129-135.	ion	
	1R	Rechid, et al. Solid Films; (2	Characterising Sup 2000) pgs. 361-362	erstrat 2.	e CIS solar cells with	electron beam induc	ed current; Th	nin	
	15	Ward, et al. 0 10/01.	Cu(In,Ga)Se2 Thin-F	ilm Co	ncentrator Solar Cells	s; NCPV Program Rev	view Meeting;	<u>.</u>	
	NER								

Rev 05/03 (PTO1449)

Sheet 2 of 5

		O-1449 PATENTS AND PU	BLICATIONS FOR	1	TTY. DOCKET NO. 100201669-1 PPLICANT	/	APPLICATION NO). CONFIRMA	TION NO
		NT'S INFORMATION	N DISCLOSURE		Ashton, et al				
	(He			F	FILING DATE		GROUP		
(Use several sheets if necessary)					Sept. 3, 2003				
REFERE	NCE D	ESIGNATION	U.S. PA	ATENT	DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE		NAME		Pages, Columns, Lines Where Relevant Passages or Figures Appear		
	2A								
	2B								
	2C								
-	2D								
	2E								
-	2F								
	2G								
	2H								
	21								
	2J								
-	2K								
		DOCUMENT NUMBER	PUBLICATION DATE		ME OF PATENTEE DR APPLICANT		Pages/Columns/Li vant Passages/Fi		Check if Translation attached
	2L								
	2M					_			+
	2N								+
	20								+
	2P]			
		OTHER REFE	ERENCES (includi	ng Autl	nor, Title, Date, F	Pertine	nt Pages, etc	.)	
	2Q	Scofield, et al. polycrystalline	Sputtered molybde thin-film solar cells	enum bil s; Thin S	ayer back contact folid Films (1995) p	for cop pgs. 26	pper indium dis 3-31	elenide-based	
	2R	Gabor, et al. H films; America	ligh-efficiency Culn n Institute of Physi	xGa1·xS cs, (199	Se2 solar cells mad (4) pgs. 198-200	de from	ı (Inx,Ga1-x)2S	e3 precursor	
				_					
	2S	Nakayama, et al. AES, LEELS and XPS studies on the interface formation between layered semiconductors GaSe and InSe; Surface Science (1991)							
EXAM	EX A MINER				DATE CONSIDE	ERED			
EXAM	IINER				DATE CONSIDE	ERED			

Sheet 3 of 5

		O-1449 PATENTS AND PUI	RI ICATIONS FOR	1002016	69-1	APPLICATION NO. CONFIRM	MATION N		
		NT'S INFORMATIO	N DISCLOSURE		APPLICANT Ashton et al				
	/Us	e several sheets if	•	Ashton, e		GROUP			
		e several silects il	necessary)	Sept. 3, 2	2003				
REFEREN	NCE D	DESIGNATION	U.S. PA	TENT DOCUME	NT DOCUMENTS				
XAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE	NA M	E	Pages, Columns, Lines Wh Relevant Passages or Figures	ere Appear		
	ЗА								
	3B			,					
	3C								
	3D								
	3E								
	3F								
	3G		· · · · · · · · · · · · · · · · · · ·						
	3H			ļ					
	31								
	31								
	ЗК								
			FOR	REIGN PATENT I	DOCUME	NTS			
	21	DOCUMENT NUMBER	PUBLICATION DATE	NAME OF PAT OR APPLICA	ENTEE	Pages/Columns/Lines Where Relevant Passages/Figures Appea	Check Translati attache		
	3L		PUBLICATION	NAME OF PAT	ENTEE	Pages/Columns/Lines Where	Translati		
	3М		PUBLICATION	NAME OF PAT	ENTEE	Pages/Columns/Lines Where	Translati		
	3M 3N		PUBLICATION	NAME OF PAT	ENTEE	Pages/Columns/Lines Where	Translat		
	3M 3N 3O		PUBLICATION	NAME OF PAT	ENTEE	Pages/Columns/Lines Where	Translati		
	3M 3N	NUMBER	PUBLICATION DATE	NAME OF PAT OR APPLICA	ENTEE	Pages/Columns/Lines Where	Translati		
	3M 3N 3O	NUMBER OTHER REFE	PUBLICATION DATE	NAME OF PAT OR APPLICA	ENTEE	Pages/Columns/Lines Where Relevant Passages/Figures Appea	Translati attache		
	3M 3N 3O 3P	OTHER REFE Nishida, et al. S American Insitu	PUBLICATION DATE RENCES (includir Single-beam overwite of Physics (198	NAME OF PAT OR APPLICA ag Author, Title, rite experiment us 7) pgs. 667-669	Date, Pe	Pages/Columns/Lines Where Relevant Passages/Figures Appea	Translat attache		
	3M 3N 3O 3P	OTHER REFE Nishida, et al. S American Insitu	RENCES (including the of Physics (198) et al. Optical and pepitaxy; Journal of	NAME OF PAT OR APPLICA on APPLICA ng Author, Title, rite experiment us 7) pgs. 667-669 on otovoltaic prop Applied Physics	Date, Pessing In-Se	Pages/Columns/Lines Where Relevant Passages/Figures Appea	dia;		

Sheet 4 of 5

FORM PTO-1449					ATTY. DOCKET NO. 100201669-1	APPLICATION NO. CONFIRMA	TION NO		
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE					APPLICANT				
A	PPLICAT	STATEN			Ashton, et al				
	(Use	e several sheets if	necessarv)		FILING DATE Sept. 3, 2003	GROUP			
									
REFERE	REFERENCE DESIGNATION U.S. PATE			TENT	DOCUMENTS				
EXAMINEF INITIAL	1	DOCUMENT NUMBER	PUBLICATION DATE		NAME	Pages, Columns, Lines Where Relevant Passages or Figures Appear			
	4A								
	4B								
	4C								
	4D								
	4E								
	4F								
	4G								
	4H								
	41								
	4J								
	4K								
		DOCUMENT NUMBER	PUBLICATION DATE		ME OF PATENTEE OR APPLICANT	Pages/Columns/Lines Where Relevant Passages/Figures Appear	Check if Translation attached		
	4L						1		
	4M								
	4N						 		
	40						<u> </u>		
	4P						<u> </u>		
		OTHER REFE	RENCES (includir	ng Auf	thor, Title, Date, P	Pertinent Pages, etc.)			
	4Q	Emery, et al. R compounds gr	eflection high-energown by molecular b	gy elec eam e	etron diffraction stud pitaxy; Journal of A	lies of InSe and GaSe layered pplied Physics (1992) pgs. 3256-32	259		
	4R	Tatsuyama, et Science (1989	al. Heteroepitaxy b) pgs. 539-543	etw ee	n layered semicondu	uctors GaSe and InSe; Applied Surf	ace		
	48	Gashimzade, e Z. Physics (19	t al. Eneregy spect 96) pgs. 219-222	rum ar	nd effective mass of	carriers in the InSe/GaSe superlatti	ce;		
EXAN		<u> </u>							

Sheet 5 of 5

FORM PTO-1449					TTY. DOCKET NO. 00201669-1	APPLICATION NO.	CONFIRMATIO	ON NO	
1 15	TOFP	ATENTS AND PUI	RUCATIONS FOR		APPLICANT				
		IT'S INFORMATIO	N DISCLOSURE		Ashton, et al				
				F	ILING DATE	GROUP			
	(Use	several sheets if	necessary)	S	ept. 3, 2003			_	
REFEREN	NCE D	ESIGNATION	U.S. PA	TENT	DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE		NAME	Pages, Column Relevant Passages	Pages, Columns, Lines Where Relevant Passages or Figures Appea		
	5A							_	
	5B							_	
	5C							_	
	5D							_	
	5E								
	5F								
	5G								
	5H								
	51			+				_	
	5J			1				_	
	5K								
	ļl								
			FOR	REIGN F	PATENT DOCUME	ENTS			
		DOCUMENT NUMBER	PUBLICATION DATE		ME OF PATENTEE OR APPLICANT	Pages/Columns/Lin Relevant Passages/Fig	···ros Annoar l'	Check if ranslation attached	
_	5L								
	5M								
	5N							_	
	50								
	5P								
	<u> </u>	OTHER REFE	RENCES (including	ng Auth	nor, Title, Date, P	Pertinent Pages, etc.)		
	5Q	Shigetomi, et a Journal of App	al. Electrical and ph blied Physics; (2000	otovolta)); pgs.	nic properties of Cu 1520-1524	-doped p-GaSe/n-InSe	heterojunction;	;	
	5R								
	58								
EXAM	INER	<u> </u>			DATE CONSIDER	RED			
EXAM					DATE CONSIDER	RED			